


<b>Search Notes</b>  	<b>Application/Control No.</b>  10058173	<b>Applicant(s)/Patent Under Reexamination</b>  STEFANIK ET AL.
	<b>Examiner</b>  Zhen, Li B	<b>Art Unit</b>  2194

**SEARCHED**

Class	Subclass	Date	Examiner
717	171,172,173,177	6/27/2007	LZ
update	search	12/4/07	LZ

**SEARCH NOTES**

Search Notes	Date	Examiner
EAST (US-PGPUB;USPAT;USOCR;EPO;DERWENT;IBMTDB) See search history printout	6/27/2007	LZ
Inventor Name Search	6/27/2007	LZ
EAST (US-PGPUB;USPAT;USOCR;EPO;DERWENT;IBMTDB) See search history printout	12/4/07	LZ

**INTERFERENCE SEARCH**

Class	Subclass	Date	Examiner